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Internal dynamics of long Josephson junction oscillators

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Numerical computations on a sine-Gordon model of the Josephson junction fluxon oscillator are compared with experimental measurements. Good agreement is found for the voltage current characteristic, oscillator power output, and range of current bias over which oscillation is observed. Our numerical results imply a "bunched-fluxon" mode of oscillation at larger values of bias current.

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The fluxon oscillator was conceived by Fulton and Dynes¹ to explain the appearance of zero field steps (ZFS) in the voltage-current (V - I) characteristics of long Josephson junctions, and exploratory measurements of microwave power output have been reported by several authors.² Recent analog³ and numerical studies⁴ have suggested that congealed (or "bunched") fluxon states, previously studied in relation to traveling waves,⁵ may play an important role in the dynamics of fluxon oscillators. This suggestion is supported by very careful measurements made within the past few months⁶ on niobium-lead junctions fabricated in the Department of Physics at the University of Salerno.⁷

In this letter we compare some of these recent measurements with results from a detailed numerical study based upon the (normalized) perturbed sine-Gordon equation⁸

$$\phi_{xx} - \phi_{tt} - \sin\phi = \alpha\phi_t - \beta\phi_{xxt} - \gamma. \quad (1)$$

Here ϕ is magnetic flux normalized to $\hbar/2e$, x is longitudinal distance normalized to λ_J , and t is time normalized with respect to the Josephson "plasma" frequency ω_0 . The right-hand term in α represents dissipation caused by normal electrons crossing the junction. It is computed as

$$\alpha = V_N / (RI_0), \quad (2)$$

where R is an effective normal resistance, I_0 is the maximum zero voltage (Josephson) current, and V_N is a normalizing voltage defined by⁸

$$V = V_N \phi_t. \quad (3)$$

The loss parameter β is the reciprocal of the Q of the superconductor surface impedance at ω_0 (Ref. 9) and is equal to 0.02 for the niobium-lead junctions considered here.¹⁰ Finally, γ is bias current measured in units of the Josephson current I_0 .

Throughout the computations we have maintained "open-circuit" boundary conditions, i.e., $\phi_x(0,t) = \phi_x(L,t) = 0$, where L is the length of the junction measured in units of λ_J . For the results reported here the initial conditions were two fluxons located at $L/3$ and $2L/3$,

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thus putting us on the second ZFS. For a fixed number of fluxons the ultimate oscillations were usually independent of the details of the initial conditions, but to obtain fluxon confinement for shorter junctions, it was necessary to launch them with sufficient initial velocity (for example 0.9 on the $L = 6$ junction discussed below). We have used an implicit finite difference scheme with a corrector loop for the nonlinear term and averaging of the second space derivative over two time steps. The time and space steps used were 0.05 and 0.1, respectively. The accuracy of our computations was checked by a systematic halving and doubling of both time and space steps.

Typical numerical results that clearly show the bunched fluxon oscillation mode are presented in Fig. 1.¹¹ The inset shows ϕ_t [voltage from Eq. (3)] at one end of the junction for four periods of the oscillation. The numerical integration was carried on until the first three Fourier components of $\phi_t(L,t)$ remained constant to within 2%. (For larger values of γ this required several hundred thousand time steps.) The zero-order Fourier component (average value) of ϕ_t corresponds [again through Eq. (3)] to the dc junction voltage. Thus a plot of $\langle \phi_t \rangle V_N$ vs γ , as shown in Fig. 2a,

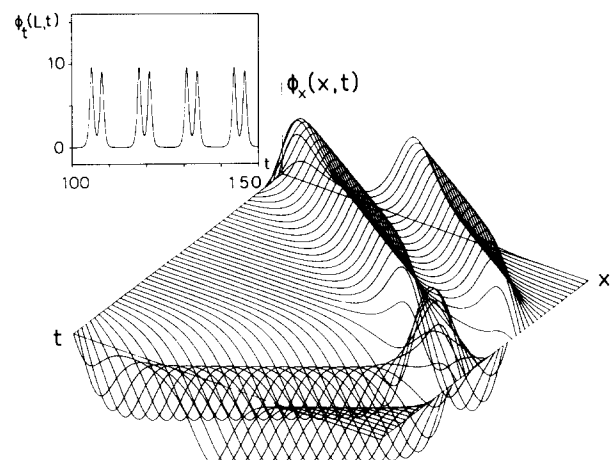


FIG. 1. Bunched-fluxon solution of Eq. (1) with $\alpha = 0.05$, $\beta = 0.02$, $\gamma = 0.3$, $L = 6$, and two fluxons. Approximately one period of $\phi_t(x,t)$ is plotted for $150 \leq t \leq 160$. The inset shows $\phi_t(L,t)$ for $100 \leq t \leq 150$.

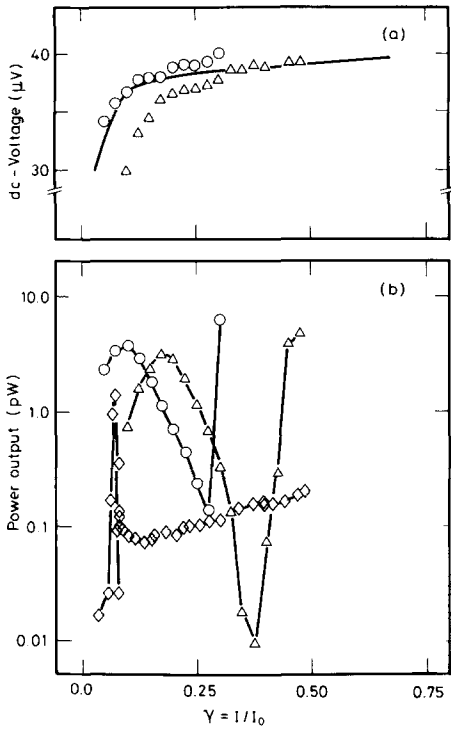


FIG. 2. Comparison of numerical calculations [with $\beta = 0.02$, $L = 6$, $\alpha = 0.01$ (\circ), and $\alpha = 0.05$ (Δ)] with measurements on a corresponding niobium-lead Josephson junction oscillator. (a) Average voltage vs current (second zero field step): Measurements (solid line). (b) Power output vs current bias: Measurements (solid-diamond line). Calculated power is into a free-space load of 377Ω .

should correspond to the second ZFS in the V - I characteristic of the junction. Since the normal current across the junction is not proportional to voltage, the effective resistance [R in Eq. (2)] is somewhat difficult to define, but for the particular junction displayed in Fig. 2a, α lies between 0.01 and 0.05. We see that the lower value of α gives better agreement for lower γ and the larger value for larger γ .

The first harmonic of our numerical computation rises monotonically with γ . This is not displayed because corresponding measurements are not available. For the second harmonic, however, direct measurements of the output power have been made.¹² This is plotted in Fig. 2b and compared with our numerical calculations. Since the Josephson junction is loosely coupled to the microwave output circuit,¹² we estimate the output power as (second harmonic component of ϕ_1)² $V_N^2 /$ (twice the free-space impedance). As is noted on Fig. 2b, this is the second-harmonic power into 377Ω . There is a fair agreement between calculated and measured levels of output power and the range of γ over which two-fluxon oscillation occurs. In addition, both show a pronounced "peak" and "dip" as bias current is changed. From the numerical results it is clear that the dip arises *not* from a change in mode structure but merely represents the situation in which the fluxon bunches (see inset of Fig. 1) occupy approximately one half-cycle. Thus one should be cautious about interpreting the experimental dip as caused by a mode shift. The numerical results do indicate a change of mode structure from the bunched oscillation shown in Fig. 1 to the symmetric oscillation of Fig. 3, but this change takes place

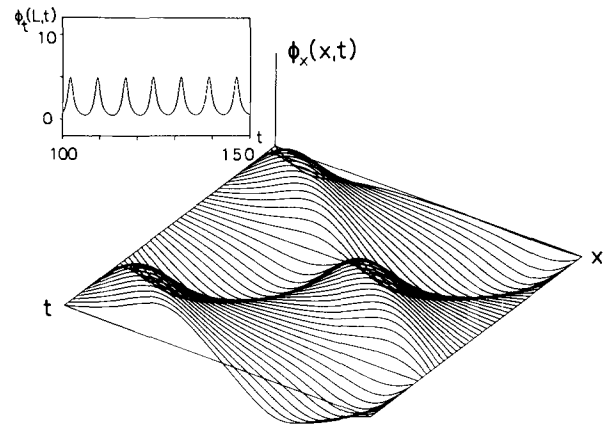


FIG. 3. Symmetric solution of Eq. (1) with $\alpha = 0.05$, $\beta = 0.02$, $\gamma = 0.125$, $L = 6$, and two fluxons. Approximately one period of $\phi_x(x,t)$ is plotted for $150 < t < 160$. The inset shows $\phi_1(L,t)$ for $100 < t < 150$.

gradually as γ is reduced and bunched behavior is completely extinguished at the peak rather than the dip. Although the oscillation of Fig. 3 is a solution of the perturbed sine-Gordon Eq. (1), it seems most natural to interpret it as a current-driven cavity mode. Note from the inset of Fig. 3 that the frequency has doubled. Thus it is the first-harmonic power which is plotted on Fig. 2b; this corresponds to the experimental measurements.^{6,12} The differences between calculated and measured locations of the dips and widths of the peaks may be caused by a number of factors including (i) poor representation of the nonlinear conduction current by a linear resistance in Eq. (2); note from Fig. 2(a) that the V - I characteristic is not particularly well represented in the low γ range; (ii) an underestimate of the effective Josephson current as the maximum zero voltage current. This would lead to an underestimate of the normalized junction length. Since the dip in the second harmonic occurs when the bunch occupies about a half-cycle, longer junctions should show the dip at lower values of bias current.

We are currently exploring the parameter space (α , β , γ , and L) to determine the range of stability for N -fluxon oscillations.

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The crystallographic orientation of A_{15} V_3Ga and Nb_3Al precipitates in BCC matrices

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Convergent-beam transmission electron diffraction was used to determine the crystallographic orientation of submicron-sized A_{15} structure V_3Ga and Nb_3Al precipitates formed by solid-state precipitation from supersaturated BCC solutions. In each case the crystallographic orientation relation was (to within an uncertainty of $\pm 5^\circ$): $[001]_{A_{15}} \parallel [111]_{BCC}$; $(100)_{A_{15}} \parallel (1\bar{1}0)_{BCC}$. This lattice correspondence is intuitively plausible, since it ensures that the closest packed planes and directions of the precipitate parallel to those of the matrix.

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Crystalline compounds of the A_{15} structure are of scientific and engineering interest because of their excellent superconducting properties. The promising A_{15} compounds are, however, invariably brittle and therefore cannot be directly formed into superconducting wire or tape. A_{15} superconducting materials are hence usually manufactured in a two-step process, in which wire or tape containing the metallic constituents of the A_{15} structure is rolled, drawn, or extruded, and the A_{15} compound is subsequently introduced through an appropriate thermal treatment which causes its precipitation in the solid state. To establish metallurgical control over the processing of A_{15} superconducting materials it is important to achieve a fundamental understanding of the crystallography, mechanism, and kinetics of the relevant precipitation reactions.

The present investigation was undertaken to determine the common crystallographic relations which govern the orientation of A_{15} precipitates in BCC media. The two cases specifically studied were V_3Ga (A_{15}) in a vanadium-rich V-Ga solid solution (BCC) and Nb_3Al (A_{15}) in a niobium-rich Nb-Al solid solution (BCC). Samples were made¹⁻³ by casting and homogenizing solute-rich metallic solid solutions, deforming these into thin tapes by warm rolling, and aging at intermediate temperature to precipitate the A_{15} phase. The specific examples illustrated in the accompanying figures are (i) V-18-at. % Ga, deformed 90% and aged at 700 °C for 12 h, and (ii) Nb-18-at. % Al, deformed 99% and aged at 750 °C for 3 h. Thin-foil specimens for transmissions electron microscopic analysis were thinned from these tapes,⁴ and ex-

amined through both conventional⁵ and convergent beam^{6,7} electron diffraction analyses to determine the crystallographic relations between the A_{15} precipitates and the BCC matrix phase.

The analysis of the V_3Ga precipitate is illustrated in Fig. 1(a)-(c). The transmission electron micrograph presented in Fig. 1(a) shows the precipitates present in a deformed V-18-at. % Ga sample after aging at 700 °C for 12 h. The V_3Ga precipitates are lenticular in shape and have an average size of ~ 3000 Å length by 1300 Å width. A typical convergent-beam diffraction pattern from this sample is shown in Fig. 1(b): the disk shape of the diffraction spots is due to the angular convergence of the incident electron beam.⁶ The diffraction pattern is indexed in Fig. 1(c). The zone axes of the BCC matrix and the A_{15} precipitates are $[111]$ and $[001]$, respectively. The rows of parallel matrix and precipitate spots in the diffraction pattern indicate parallel planes (within $\pm 5^\circ$), since the corresponding reflecting planes are almost parallel to the electron beam (Bragg angle $< 1^\circ$).⁵ It follows that the (100) plane of the A_{15} precipitate is essentially parallel to the $(1\bar{1}0)$ plane of the BCC matrix. The complete orientation relation is hence given by the appealingly simple correspondence:

$$[001]_{A_{15}} \parallel [111]_{BCC}; (100)_{A_{15}} \parallel (1\bar{1}0)_{BCC}. \quad (1)$$

The analysis of the Nb-Al system is illustrated in Fig. 2(a)-2(b). The transmission electron micrograph presented in Fig. 2(a) shows that the Nb_3Al precipitates formed from Nb-18-at. % Al on aging at 750 °C for 3 h are morphologi-